# SEMICONDUCTOR FDMS8558SDC

# N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>

# **25 V, 90 A, 1.5 m**Ω

### Features

- Dual Cool<sup>TM</sup> PQFN package
- Max r<sub>DS(on)</sub> = 1.5 mΩ at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 38 A
- Max  $r_{DS(on)} = 1.7 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 36 \text{ A}$
- High performance technology for extremely low r<sub>DS(on)</sub>
- SyncFET<sup>TM</sup> Schottky Body Diode
- RoHS Compliant

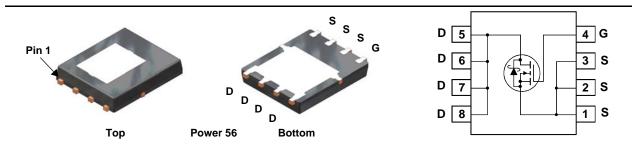


### **General Description**

This N-Channel SyncFET<sup>TM</sup> is produced using Fairchild PowerTrench® Semiconductor's advanced process. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{\text{DS(on)}}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance. This device has the added benefit of an efficient monolithic Schottky body diode.

### Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side



### **MOSFET Maximum Ratings** $T_A = 25^{\circ}C$ unless otherwise noted

| Symbol                            | Parameter                                     |                        |           | Ratings     | Units |  |
|-----------------------------------|---|------------------------|-----------|-------------|-------|--|
| V <sub>DS</sub>                   | Drain to Source Voltage                       |                        |           | 25          | V     |  |
| V <sub>GS</sub>                   | Gate to Source Voltage                        |                        |           | 12          | V     |  |
|                                   | Drain Current -Continuous (Package limited)   | T <sub>C</sub> = 25 °C |           | 90          |       |  |
| I <sub>D</sub>                    | -Continuous                                   | T <sub>A</sub> = 25 °C | (Note 1a) | 38          | Α     |  |
|                                   | -Pulsed                                       |                        |           | 140         |       |  |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy                 |                        | (Note 3)  | 145         | mJ    |  |
| P <sub>D</sub>                    | Power Dissipation                             | T <sub>C</sub> = 25 °C |           | 89          | 14/   |  |
|                                   | Power Dissipation                             | T <sub>A</sub> = 25 °C | (Note 1a) | 3.3         | W     |  |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Ra | ange                   |           | -55 to +150 | °C    |  |

### **Thermal Characteristics**

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case    | (Top Source)   | 2.8 |      |
|-----------------|---|----------------|-----|------|
| $R_{\thetaJC}$  | Thermal Resistance, Junction to Case    | (Bottom Drain) | 1.4 |      |
| $R_{\thetaJA}$  | Thermal Resistance, Junction to Ambient | (Note 1a)      | 38  |      |
| $R_{\thetaJA}$  | Thermal Resistance, Junction to Ambient | (Note 1b)      | 81  | °C/W |
| $R_{\thetaJA}$  | Thermal Resistance, Junction to Ambient | (Note 1i)      | 16  | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1j)      | 23  |      |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1k)      | 11  |      |

### **Package Marking and Ordering Information**

| Device Marking | Device      | Package  | Reel Size | Tape Width | Quantity   |
|----------------|-------------|----------|-----------|------------|------------|
| 09DC           | FDMS8558SDC | Power 56 | 13"       | 12 mm      | 3000 units |

July 2013

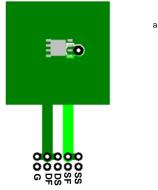
| Symbol                                     | Parameter   | Test Conditions   | Min | Тур                | Max        | Units         |
|--|---|---|-----|--------------------|------------|---------------|
| Off Chara                                  | acteristics   |   |     |                    |            |               |
| BV <sub>DSS</sub>                          | Drain to Source Breakdown Voltage                                     | I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V  | 25  |                    |            | V             |
| $\Delta BV_{DSS}$<br>$\Delta T_J$          | Breakdown Voltage Temperature<br>Coefficient                          | $I_D = 10 \text{ mA}$ , referenced to 25 °C   |     | 24                 |            | mV/°C         |
| DSS  | Zero Gate Voltage Drain Current                                       | $V_{DS} = 20 V, V_{GS} = 0 V$   |     |                    | 500        | μA            |
| GSS  | Gate to Source Leakage Current  | $V_{GS}$ = +12 V/-8 V, $V_{DS}$ = 0 V   |     |                    | ±100       | nA            |
| On Chara                                   | octeristics   |   |     |                    |            |               |
| V <sub>GS(th)</sub>                        | Gate to Source Threshold Voltage                                      | $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$   | 1.1 | 1.4                | 2.2        | V             |
| $\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$  | Gate to Source Threshold Voltage<br>Temperature Coefficient           | $I_D = 10 \text{ mA}, \text{ referenced to } 25 \text{ °C}$   |     | -3                 |            | mV/°C         |
| 5  |   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 38 A   |     | 1.1                | 1.5        |               |
| r <sub>DS(on)</sub>                        | Static Drain to Source On Resistance                                  | $V_{GS} = 4.5 \text{ V}, I_D = 36 \text{ A}$  |     | 1.3                | 1.7        | mΩ            |
| ()   |   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 38 A, T <sub>J</sub> = 125 °C  |     | 1.6                | 2.1        | +             |
| 9FS  | Forward Transconductance  | $V_{DS} = 5 V, I_D = 38 A$  |     | 317                |            | S             |
| C <sub>oss</sub><br>C <sub>rss</sub><br>Rg | Output Capacitance<br>Reverse Transfer Capacitance<br>Gate Resistance | f = 1 MHz   |     | 1508<br>195<br>0.9 |            | pF<br>pF<br>Ω |
|  |   |   |     | 0.9                |            | Ω             |
|  | g Characteristics   |   |     | 1                  |            | 1             |
| t <sub>d(on)</sub>                         | Turn-On Delay Time  | _   |     | 14                 |            | ns            |
| t <sub>r</sub>                             | Rise Time   | $V_{DD} = 13 \text{ V}, I_D = 38 \text{ A},$  |     | 8                  |            | ns            |
| d(off)                                     | Turn-Off Delay Time   | $V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$   |     | 51                 |            | ns            |
| f  | Fall Time   |   |     | 7                  |            | ns            |
| Qg   | Total Gate Charge   | $V_{GS} = 0 V \text{ to } 10 V$   |     | 81                 |            | nC            |
| Q <sub>g</sub>                             | Total Gate Charge   | $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V},$<br>$I_D = 38 \text{ A}$                                       |     | 38                 |            | nC            |
| Q <sub>gs</sub>                            | Gate to Source Gate Charge<br>Gate to Drain "Miller" Charge           |   |     | 10<br>9.7          |            | nC<br>nC      |
| Q <sub>gd</sub>                            |   |   |     | 5.1                |            | ne            |
| Jrain-Soi                                  | urce Diode Characteristics  |   |     |                    |            |               |
| V <sub>SD</sub>                            | Source to Drain Diode Forward Voltage                                 | $V_{GS} = 0 \text{ V}, \text{ I}_{S} = 2 \text{ A} $ (Note 2)<br>$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 38 \text{ A} $ (Note 2) |     | 0.6<br>0.8         | 0.8<br>1.2 | V             |
| 00   | Reverse Recovery Time   |   |     | 35                 |            | ns            |
| t <sub>rr</sub>                            | Reverse Recovery fille  | — I <sub>F</sub> = 38 A, di/dt = 300 A/μs   |     |                    |            |               |

# **Thermal Characteristics**

| $R_{	extsf{	heta}JC}$ | Thermal Resistance, Junction to Case    | (Top Source)   | 2.8 |      |
|-----------------------|---|----------------|-----|------|
| $R_{	extsf{	heta}JC}$ | Thermal Resistance, Junction to Case    | (Bottom Drain) | 1.4 |      |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a)      | 38  |      |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b)      | 81  |      |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1c)      | 27  |      |
| $R_{	ext{	heta}JA}$   | Thermal Resistance, Junction to Ambient | (Note 1d)      | 34  |      |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1e)      | 16  | °C/W |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1f)      | 19  | °C/W |
| $R_{\theta JA}$       | Thermal Resistance, Junction to Ambient | (Note 1g)      | 26  |      |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1h)      | 61  |      |
| $R_{\theta JA}$       | Thermal Resistance, Junction to Ambient | (Note 1i)      | 16  |      |
| $R_{	ext{	heta}JA}$   | Thermal Resistance, Junction to Ambient | (Note 1j)      | 23  |      |
| $R_{\theta JA}$       | Thermal Resistance, Junction to Ambient | (Note 1k)      | 11  |      |
| $R_{\theta JA}$       | Thermal Resistance, Junction to Ambient | (Note 1I)      | 13  |      |

NOTES

1. R<sub>0,JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0,JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper

c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

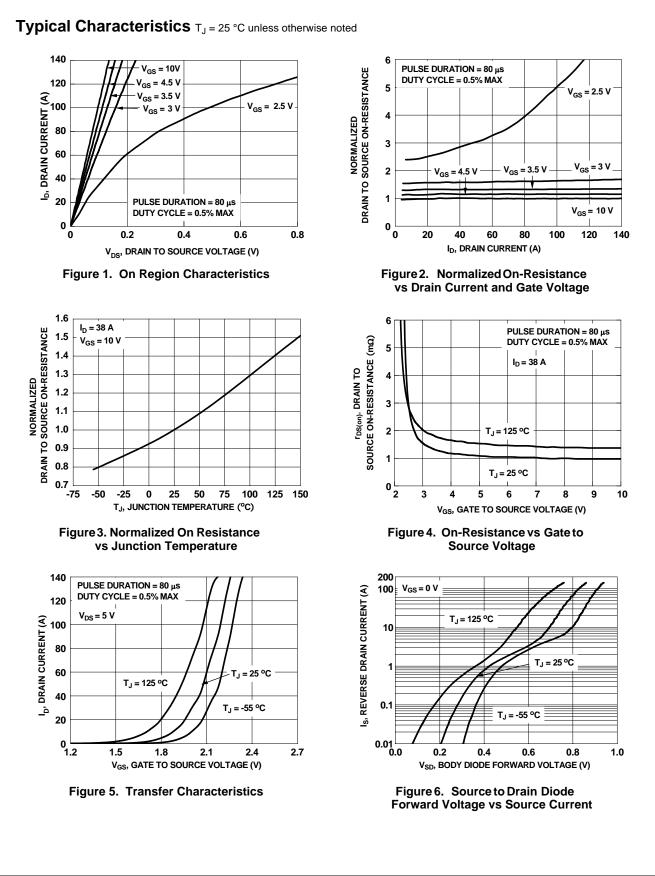
j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

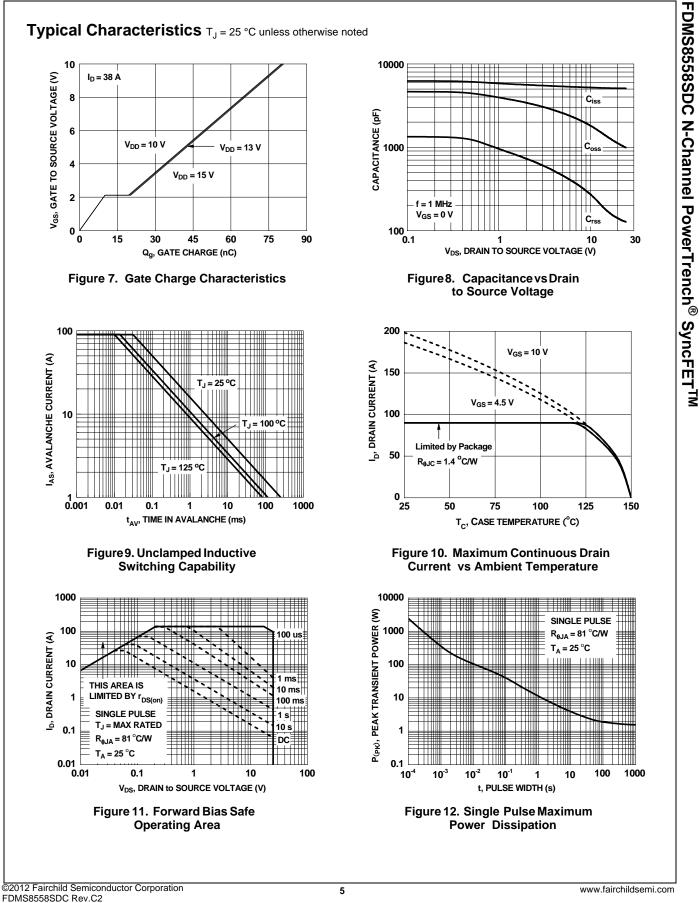
I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

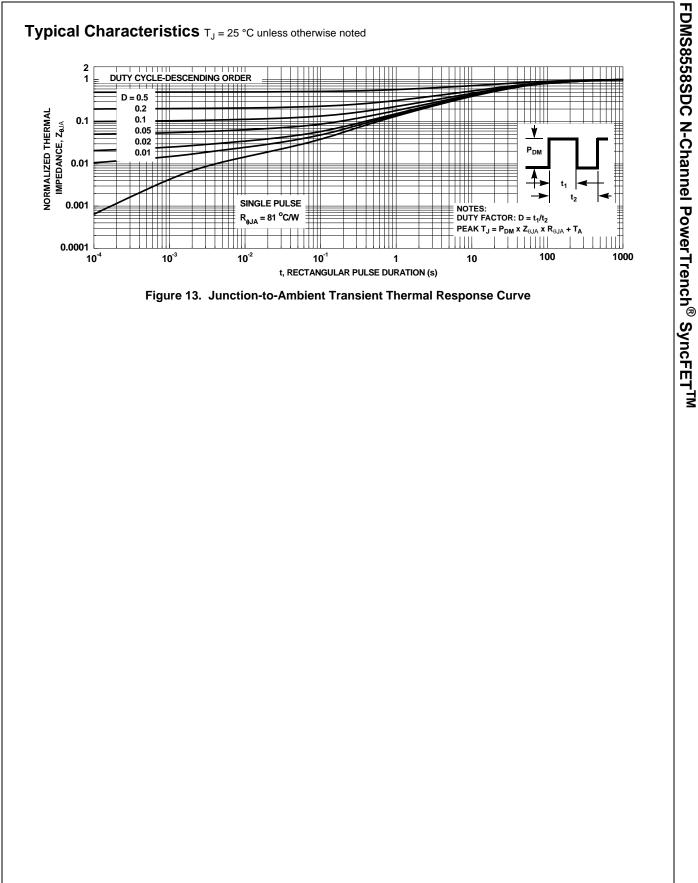
2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%. 3. E<sub>AS</sub> of 145 mJ is based on starting T<sub>J</sub> = 25 °C, L = 0.9 mH, I<sub>AS</sub> = 18 A, V<sub>DD</sub> = 23 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 39 A.

FDMS8558SDC N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>



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# FDMS8558SDC N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>

### Typical Characteristics (continued)

## SyncFET<sup>™</sup> Schottky body diode Characteristics

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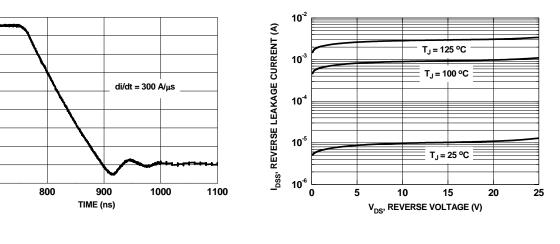
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5

0 -5 700

Fairchild's SyncFET<sup>TM</sup> process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS8558SDC.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

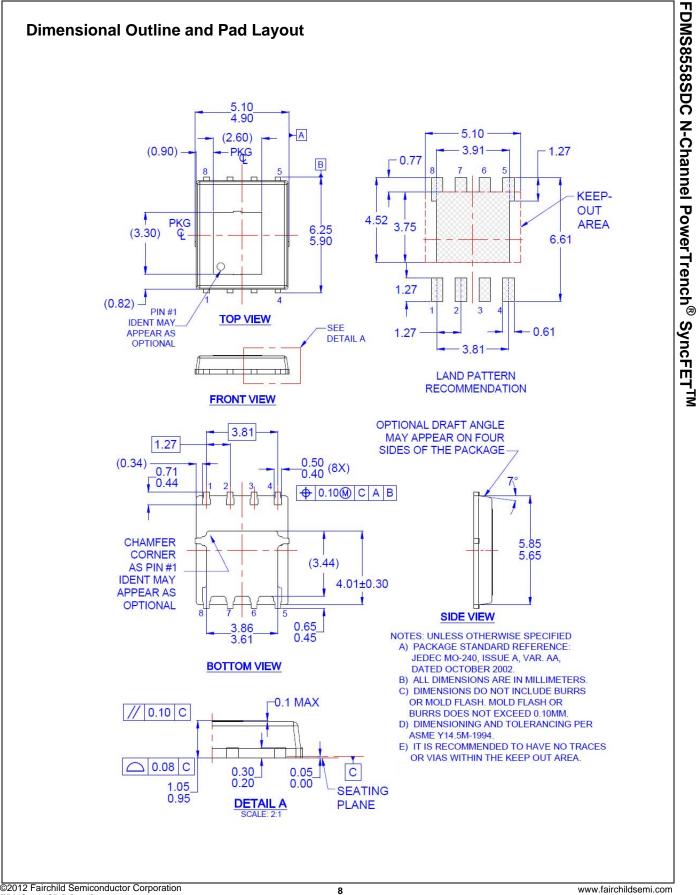


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Figure 14. FDMS8558SDC SyncFET<sup>™</sup> body diode reverse recovery characteristic

Figure 15. SyncFET<sup>TM</sup> body diode reverse leakage versus drain-source voltage

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